

STABILOCK 4031: Technical Data

Synthesizer

Spectral purity		10-MHz reference oscillator	
• Phase noise (25-kHz offset)		• Nonharmonic spurious signals > 500 Hz off carrier	< 55 dBc
f < 500 MHz	< -121 dBc/Hz	• Harmonics	< -25 dBc
f ≥ 500 MHz	< -115 dBc/Hz	Level < -15.1 dBm	< -20 dBc
• Residual FM		Level ≥ -15.1 dBm	< 0.02 % (rms, CCITT-weighted)
f < 500 MHz	4 Hz (rms, CCITT-weighted)	• Residual AM	CCITT-weighted)
f ≥ 500 MHz	8 Hz (rms, CCITT-weighted)		
		• Frequency error	
		• Aging	< 3 min for frequency error < 5 · 10 ⁻⁷ (T = 20 °C)
		• Output level	< 10 min for frequency error < 10 ⁻⁷
		• Synchronization	< 1 · 10 ⁻⁷ (T = 0 to 45 °C) < 5 · 10 ⁻⁸ /month approx. 0.4 V (into 50 Ω) 10 MHz, V > 150 mV _{ms} (into 200 Ω)

Receiver test

Carrier frequency		Output level		Level error into 50 Ω	
• Frequency range	0.4 to 999.9999 MHz	• RF socket	-142 to -7 dBm (max. -13 dBm with AM)	RF socket	< 1.3 dB
• Resolution		• RF DIRECT socket	-122 to +13 dBm (max. +7 dBm with AM)	Level ≥ -130 dBm	< 2 dB
f < 500 MHz	50 Hz	• Resolution	0.1 dB	RF DIRECT socket	
f ≥ 500 MHz	100 Hz			Level ≥ -110 dBm	< 1.8 dB
• Frequency error	as reference oscillator			Level > +5.0 dBm	< 2.5 dB
				VSWR (50 Ω) RF socket	< 1.1
				EMF setting range without interruption (not with AM)	0 to 20 dB
				Additional level error	0.1 dB per dB

RX modulation

FM (AC-coupled)		FM (external DC-coupled)		AM	
• Frequency deviation	0 to 40 kHz	• Frequency deviation	0 to 5 kHz	• Modulation depth	m = 0 to 99.9%
• Modulation frequency (int. and ext.)	30 Hz to 30 kHz	• Modulation frequency	0 to 30 kHz	• Resolution	0.1 %
• Resolution	10 Hz	• Centre-frequency error	< 100 Hz + frequency error of reference oscillator	• Modulation frequency	30 Hz to 10 kHz
• Setting error				• Setting error for m ≤ 90 %	
f _{mod} = 300 Hz to 3 kHz	< 5 % + 3 digits			f _{mod} = 30 Hz to 10 kHz	< 0.1 · m + 1 digit
f _{mod} = 30 Hz to 20 kHz	< 10 % + 3 digits			• Distortion for m < 50 %	< 2 %
• Distortion				f _{mod} = 300 Hz to 3 kHz	50 % AM =
dev. < 10 kHz, f _{mod} = 300 Hz to 3 kHz	< 1 %	• Phase deviation	0 to 6 rad (f _{mod} · rad ≤ 20 kHz)	0.707 V _{ms} into 600 Ω	0.707 V _{ms} into 600 Ω
• Ext. mod. input	20 kHz FM = 0.707 V _{ms} into 600 Ω	• Resolution	0.01 rad		
		• Modulation frequency	200 Hz to 6 kHz		
		• Setting error	< 6 % + 0.02 rad		
		f _{mod} = 300 Hz to 3 kHz			
		• Distortion	< 1 %		
		f _{mod} = 300 Hz to 3 kHz			
		• Ext. mod. input	20 rad FM = 0.707 V _{ms} into 600 Ω		

Transmitter test

Frequency measurement

- Frequency range 2 to 999.9999 MHz
- Resolution 10 Hz
- Admissible input level on RF socket 0.1 mW to 125 W
- Measuring error as reference oscillator + 10 Hz

Frequency-offset measurement

- Frequency range 2 to 999.9999 MHz
- Measuring range 0 to ±99.99 kHz
- Resolution f < 10 kHz 1 Hz
- f ≥ 10 kHz 10 Hz
- Admissible input level on RF socket 2 μW to 125 W
- on RF DIRECT socket 1 mV to 1 V
(measuring range: 0 to ±15 kHz)

Measuring error

- as reference oscillator + 3 Hz
- (+ 1 digit for offset ≥ 10 kHz)

RF-power measurement (broadband)

- Frequency range 2 to 999.9999 MHz
- Measuring range 1 mW to 125 W (average)
- Resolution P < 1 W 1 mW
- P < 10 W 10 mW
- P ≥ 10 W 100 mW
- Measuring error (w/o modulation) P > 200 mW < 10 % + 1 digit
(f = 20 to 500 MHz)
- < 12 % + 1 digit
(f = 6 to 999.9999 MHz)

RF-power measurement

- (bandwidth approx. 3 MHz)**
- Frequency range 2 to 999.9999 MHz
 - Measuring range RF socket 2 to 999.9999 MHz
 - RF DIRECT socket -45 to +37 dBm
 - 65 to +17 dBm
 - Measuring error < 3 dB
 - Resolution 0.1 dBm

TX modulation measurement

FM measurement, RF socket (broadband)

- Frequency range 2 to 999.9999 MHz
- Input level 0.1 mW to 125 W
- Measuring range 0 to 25 kHz
- Resolution 10 Hz
- Measuring error (dev. < 10 kHz) f_{mod} = 300 Hz to 3 kHz < 5 % + 1 digit
- + peak residual FM
- f_{mod} = 100 Hz to 10 kHz < 10 % + 1 digit
- + peak residual FM
- Demodulation distortion f_{mod} = 300 Hz to 3 kHz < 0.5 %
- < 50 Hz or
- < 10 Hz/100 MHz

FM measurement, RF DIRECT socket (narrowband)

- Frequency range 2 to 999.9999 MHz
- Input level -50 to -20 dBm
- Measuring range 0 to 10 kHz
- (f_{mod} · dev. < 10 kHz) f_{mod} = 0 to 6 kHz 10 Hz
- better than 2 μV (3 kHz FM dev., 10 dB SINAD, CCITT-weighted)
- IF bandwidth 30 kHz

FM measurement, RF socket (broadband)

- Frequency range 2 to 999.9999 MHz
- Input level 0.1 mW to 125 W
- Measuring range 0 to 6 rad (FM dev. < 50 kHz) 0.01 rad
- Resolution
- Measuring error f_{mod} = 300 Hz to 3 kHz < 6 % + 2 digits
- f_{mod} = 200 Hz to 10 kHz < 10 % + 2 digits
- Demodulation distortion f_{mod} = 300 Hz to 3 kHz < 0.5 %

FM measurement, RF DIRECT socket (narrowband)

- Frequency range 2 to 999.9999 MHz
- Input level -50 to -20 dBm
- Measuring range 0 to 3 rad (f_{mod} · FM dev. < 15 kHz)
- Modulation frequency 200 Hz to 6 kHz
- Sensitivity better than 2 μV (3 rad FM dev., 10 dB SINAD, CCITT-weighted)
- IF bandwidth 30 kHz

AM measurement

- Frequency range 2 to 999.9999 MHz
- Measuring range 0 to 100 %
- Input level RF socket 1 mW to 125 W
- RF DIRECT socket 0.01 mW to 0.5 W
- Resolution 0.1 %
- Measuring error (m ≥ 10 %) f_{mod} = 200 Hz to 10 kHz < 10 % + 2 digits
- Demodulation distortion f_{mod} = 300 Hz to 3 kHz < 1 %
- Modulation frequency DC to 10 kHz

Spurious-modulation measurement

- Input level RF socket 1 mW to 125 W
- RF DIRECT socket 20 mV to 1 V
- Measuring range 0 to -40 dB (CCITT-weighted)
referred to 3 kHz FM dev., 3 rad FM dev. or 30 % AM
- Measuring error < 1 dB

AF generator

Modulation generator GEN A

- Frequency range 30 Hz to 30 kHz
- Resolution f < 3 kHz 0.1 Hz
- f ≥ 3 kHz 1 Hz
- Frequency error < 0.01 %
- Level range (EMF) 0.1 mV_{ms} to 5 V_{ms}

- Resolution EMF ≤ 5 V 10 mV
- EMF ≤ 1 V 1 mV
- EMF ≤ 0.1 V 0.1 mV
- EMF ≤ 10 mV 10 μV
- Level error f = 100 Hz to 10 kHz < 3 %
- f = 30 Hz to 30 kHz < 10 %

- Distortion f = 30 Hz to 3 kHz < 0.5 %
- f > 3 kHz < 1 %
- Output impedance (balanced) f = 300 Hz to 3 kHz < 10 Ω
- f = 30 Hz to 30 kHz < 40 Ω
- Output impedance (unbalanced) 600 Ω ± 5 %
- Permissible load impedance > 200 Ω

AF evaluation

AF voltmeter

- Frequency range 30 Hz to 30 kHz or to CCITT P 53A
- Measuring range 0.1 mV to 20 V
- Resolution Level < 0.1 V 0.1 mV
- Level < 1 V 1 mV
- Level < 10 V 10 mV
- Level < 20 V 100 mV
- Measuring error f = 300 Hz to 3 kHz < 3 %
- f = 50 Hz to 15 kHz < 6 %
- Source impedance > 100 kΩ or 600 Ω ± 3 %
- Input capacitance 20 pF

AF counter

- Frequency range 30 Hz to 30 kHz
- Input level 5 mV to 20 V
- Resolution f < 300 Hz 0.1 Hz
- f < 10 kHz 1 Hz
- f ≥ 10 kHz 10 Hz
- Measuring error < 0.01 % + 1 digit

SINAD meter

- Input level 0.1 to 20 V
- Measuring range 1 to 46 dB
- Resolution SINAD < 30 dB 0.1 dB
- SINAD ≥ 30 dB 0.5 dB
- Measuring error for SINAD < 30 dB < 0.8 dB + 1 digit

Distortion meter

- Input level 0.1 to 20 V
- Test frequency 1 kHz ± 5 Hz
- Measuring range 0 to 99 %
- Resolution 0.1 %
- Measuring error d = 1 to 90 % < 5 % of meas. value + 3 digits

Scope & Analyzer

Spectrum analyzer

- Frequency range 2 to 999,999 MHz
- Frequency accuracy better than 2 % of sweep width
- Input-level range for measuring error < 3 dB in the frequency range 0.5 · f_c ≤ f ≤ 2 · f_c
- RF socket -70 to +47 dBm
- RF DIRECT socket -90 to +13 dBm
- Sweep width 200 kHz, 2 MHz, 10 MHz
- Sweep time approx. 500 ms
- Sweep width 2 MHz and 10 MHz approx. 2 s
- Sweep width 200 kHz

Evaluation bandwidth

- Sweep width 2 MHz and 10 MHz 30 kHz
- Sweep width 200 kHz 6 kHz
- Inherent noise on RF DIRECT socket -95 dBm
- Sweep width 2 MHz and 10 MHz -105 dBm
- Sweep width 200 kHz

Frequency range

- < 10 % + 0.2 div
- 6 × 10 div
- 100 μs/div to 500 ms/div
- 2 mV/div to 10 V/div or 160 Hz/div to 8 kHz/div (FM); 0.16 rad/div to 8 rad/div (ΦM); 0.8 %/div to 40 %/div (AM)
- ± slope selectable trigger level auto, norm, one-shot, freeze, time measurement (max. resolution 2.5 μs)

Oscilloscope

- Inputs external Z_i = 1 MΩ/40 pF (AC/DC)
- internal RX mod., TX mod., duplex demod., AF voltmeter, residual distortion

Trigger

- Operating modes auto, norm, one-shot, freeze, time measurement (max. resolution 2.5 μs)

Selective-call encoder and decoder

Standard tone sequences

ZVEI 1	CCIR	VDEW
ZVEI 2	EEA	NATEL
EIA	EURO	CCITT

User-defined tone sequences

Sequence of up to 30 tones can be stored by user. Also double tones and underlying continuous tone (with GEN B option).

Encoder

Operating modes

- Single-tone sequence (max. 30 tones)
- Double-tone sequence (with GEN B option) (single-tone and double-tone sequences can be transmitted continuously)
- Acknowledgement call (max. 15 double tones) from response time of < 100 ms acknowledgement call only possible with optional duplex FM/ΦM stage
- Frequency error: $1 \cdot 10^{-4}$ Hz

Setting ranges

With all standard and user-defined tone sequences it is possible to vary tones 1 to 15 in all parameters (tones 16 to 30: duration and pause can only be varied uniformly).

- Frequency 200 to 3000 Hz
- Resolution 0.1 Hz
- Tone duration 1 to 9999 ms at least 1 cycle
- Resolution 1 ms
- Pause duration 0 to 9999 ms
- Resolution 1 ms

Decoder

Decoding of each tone of tone sequences (max. 30 tones). Continuous decoding can be set.

Frequency measurement

- Measuring range 300 to 3000 Hz
- Resolution 0.1 Hz
- Measuring error *) < 2 digits

Tone-duration measurement

- Measuring range 40 to 9999 ms
- Resolution 0.1 ms
- Measuring error *) < 3 ms + 2 cycles of lowest frequency in tone sequence

Pause-duration measurement

- Measuring range 2 to 9999 ms
- Resolution 0.1 ms
- Measuring error *) < 3 ms + 2 cycles of lowest frequency in tone sequence

*) Measuring errors referred to signal on VOLT/M socket with level $> 360 \text{ mV}_{\text{rms}}$

Receiving bandwidth

- | | |
|---------------------------|--------------------------|
| Setting range | ± 0.1 to ± 9.9 % |
| Response-time measurement | 2 to 9999 ms |
| Resolution | 1 ms |

Options

HARDWARE OPTIONS

Duplex FM/ΦM stage

- Frequency range 27 to 999.9999 MHz
 - Input level 1 mW to 125 W
 - Measuring range 0 to 20 kHz
 - Measuring error 0 to 6 rad as for FM or ΦM measurement
 - Peak residual FM < 50 Hz or 15 Hz/100 MHz
- All other values as for FM and ΦM measurement

Tracking

This permits frequency-dependent network analysis, eg the graphic display of filter curves (screen or printer).

- Frequency range 27 to 999.9999 MHz
- Min. window width 1 MHz
- Max. frequency resolution 5 kHz/pixel
- Displayed level dynamic range 70 dB

Modulation generator GEN B

Specifications as for GEN A

Control interface A

- Changeover relays *) 8
- TTL inputs 8 (electric strength: ± 30 V)
- Trigger inputs 1

Control Interface C

- Changeover relays *) 24 (16 BCD-, BCD-inv.- or HEX-encodeable)
 - TTL control outputs 20 (open collector)
 - TTL inputs 8 (electric strength: ± 30 V)
 - TTL trigger inputs 2
- $I_{\text{max}} = 1 \text{ A}, V_{\text{max}} = 30 \text{ V}$

RS-232/Centronics interface

- Baud rate 110/150/300/600/1200/2400/4800/9600 Bd
- Transmission protocol 7/8 bits, even/odd parity, 1/2 stop bits
- Socket connectors 25-way submini D

Keyboard

ASCII keyboard for writing Autorun programs and for interactive entries (eg adjustment instructions) in the course of a program.

Option card

The option card houses the optional modules.

Modules for option card

- DTMF device
- Encoder/decoder
- Tone/pause duration user-defined
- Network C expander

DC voltmeter/ammeter

- | | |
|------------------------|------------------------|
| Voltmeter | 0 to ± 42 V |
| Measuring range | 100 μ V to 100 mV |
| Resolution | $\leq 1\% \pm 1$ digit |
| Measuring error | $\leq 1\% \pm 1$ digit |
| Ammeter | 0 to ± 15 A |
| Measuring range | 1 to 100 mA |
| Resolution | $\leq 4\% \pm 10$ mA |
| Measuring error | $\leq 4\% \pm 10$ mA |
| Variable notch filter | 200 to 600 Hz |
| 300-Hz highpass filter | |
| 300-Hz lowpass filter | |
| 3-kHz lowpass filter | |
| 4-kHz bandpass filter | |
| 6-kHz bandstop filter | |

Data module

For generating and decoding FFSK, NRZ and RZ signaling. The data module is the hardware requirement for testing cellular car telephones and radio-data systems with the software options.

VSWR test probe

- | | |
|--------------------------|---------------|
| Frequency range | 25 to 500 MHz |
| Admissible forward power | 1 to 50 W |

Options

SSB stage

TX

- Frequency range 2 MHz to 999.999 MHz
- RF power 1 mW to 125 W
- Measuring error see standard unit
- Pselectable intermodulation for power measurement 0 to 45 dB
- Test tones/frequency 2 / freely selectable
- Frequency offset ±1 kHz
- AF bandwidth 10 Hz to 30 kHz
- Carrier suppression 0 to 60 dB for f = 1 kHz
- Opposite sideband suppression 0 to 60 dB for f = 1 kHz
- Measuring error 0 to 40 dB ± 1 dB
- AGC delay time 0 to 60 dB ± 2 dB 0 to 9999 ms selectable

RX

- Carrier-frequency range 0.4 MHz to 999.999 MHz
- SSB modulation 0 to 30 kHz
- Resolution 10 Hz
- Accuracy as reference oscillator
- Intermod. meas. range for intermodulation product 0 to 50 dB 2.3 kHz or 2.7 kHz
- Measuring error ±2 dB
- Measurable sensitivity 1 to 10 dB SINAD freely selectable
- Measuring error see standard unit
- Max. RF level on RF DIRECT socket +13 dBm
- Max. RF level on RF socket -7 dBm
- Max. RF level for intermod. measurement on RF DIRECT socket -16 dBm
- Max. RF level on RF socket -15.5 dBm
- Measuring error -36 dBm

ACPM

Adjacent-channel power meter

- Standard CEPT T/R-27-01
- Frequency range 10 to 960 MHz
- Min. input level > 100 mW on RF socket
- Measuring range < -73 dBc for f < 492 MHz (typ. < -75 dBc)
- Measuring range < -70 dBc for f ≥ 492 MHz (typ. < -72 dBc)
- Measuring error < 3 dB
- Selectable channel spacing 10 / 12.5 / 20 / 25 kHz

SOFTWARE OPTIONS

Tests on car telephones and radio-data systems call for the appropriate software option on a memory card (see check-list) and the data module.

General data

Dimensions

- HxWxD 230 mm x 375 mm x 486 mm

Weight

- approx. 18.5 kg

Power supply

- AC 94 to 132 V or 187 to 264 V (47 to 450 Hz)
- DC 10.5 to 32 V approx. 110 W (incl. options)

Environment

- Operating temperature 0 to 45°C
- Storage temperature -40 to +70°C
- Relative humidity max. 90 %

Mechanical strength

- (to DIN 40046)
 - Shock 30 g
 - Vibration 5 to 10 Hz for 10 mm amplitude
 - 10 to 60 Hz, 2 g constant

RFI

- to VDE 0871 / class B corr.
- to PTT decree 1046/84

Damp tropical/cold test

- to Def. Std. 66-31 issue 1/cat. 3

Safety

- to VDE 0411/IEC 348

IEEE-bus interface

- IEEE 488
- 24-way
- AH1, SH1, L2, T1, SR1, RL1, DC1